

FDZ7064N

30V N-Channel Logic Level PowerTrench® BGA MOSFET

General Description

Combining Fairchild's 30V PowerTrench process with state of the art BGA packaging, the FDZ7064N minimizes both PCB space and $R_{\rm DS(ON)}.$ This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultra-low profile packaging, low gate charge, and low $R_{\rm DS(ON)}.$

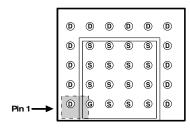
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{\text{DS(ON)}}$ specifications resulting in DC/DC power supply designs with higher overall efficiency.

Features

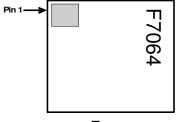
- 13.5 A, 30 V. $R_{DS(ON)} = 8.0 \ m\Omega \ @ \ V_{GS} = 4.5 \ V$ $R_{DS(ON)} = 7.0 \ m\Omega \ @ \ V_{GS} = 10 \ V$
- Occupies only 14 mm² of PCB area. Only 42% of the area of SO-8
- Ultra-thin package: less than 0.8 mm height when mounted to PCB
- 3.5 x 4 mm² Footprint
- · High power and current handling capability.

Applications

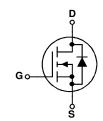
- DC/DC converters
- · Solenoid drive







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Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	ool Parameter		Ratings	Units	
V _{DSS}	Drain-Source Voltage		30	V	
V _{GSS}	Gate-Source Voltage		±12	V	
I _D	Drain Current - Continuous	(Note 1a)	13.5	A	
	- Pulsed		60		
P _D	Power Dissipation (Steady State)	(Note 1a)	2.2	W	
T _J , T _{stq}	Operating and Storage Junction Tempe	rature Range	-55 to +150	°C	

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	56	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Ball	(Note 1)	4.5	
R _{eJC}	Thermal Resistance, Junction-to-Case	(Note 1)	0.6	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
7064N	FDZ7064N	13"	12mm	3000

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics				I	I
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_D = 250 \mu\text{A}$	30			V
$\Delta BV_{DSS} \over \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		21		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μΑ
I _{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Chara	acteristics (Note 2)				•	•
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	0.8	1.2	2.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		-4.6		mV/°C
$R_{DS(on)}$	Static Drain–Source On–Resistance	$\begin{array}{cccccccccccccccccccccccccccccccccccc$		6.1 5.4 9.0	8.0 7.0 13	mΩ
g _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, \qquad I_{D} = 13.5 \text{ A}$		92		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$		3843		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		522		pF
C _{rss}	Reverse Transfer Capacitance			209		pF
Switchin	g Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, \qquad I_{D} = 1 \text{ A},$		10	20	ns
t _r	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		9	18	ns
t _{d(off)}	Turn-Off Delay Time	7		71	114	ns
t _f	Turn-Off Fall Time	7		18	32	ns
Qg	Total Gate Charge	$V_{DS} = 15 \text{ V}, \qquad I_{D} = 13.5 \text{ A},$		31	43	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 4.5 \text{ V}$		8		nC
Q_{gd}	Gate-Drain Charge			7.4		nC
Drain-Sc	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				1.8	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{S} = 1.8 \text{ A} \text{ (Note 2)}$		0.7	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 13.5 A,		30		nS
Q _{rr}	Diode Reverse Recovery Charge	$\int d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$		35		nC

Notes:

1. R_{BJA} is determined with the device mounted on a 1 in² 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, R_{BJB}, is defined for reference. For R_{BJC}, the thermal reference point for the case is defined as the top surface of the copper chip carrier. R_{BJC} and R_{BJB} are guaranteed by design while R_{BJA} is determined by the user's board design.



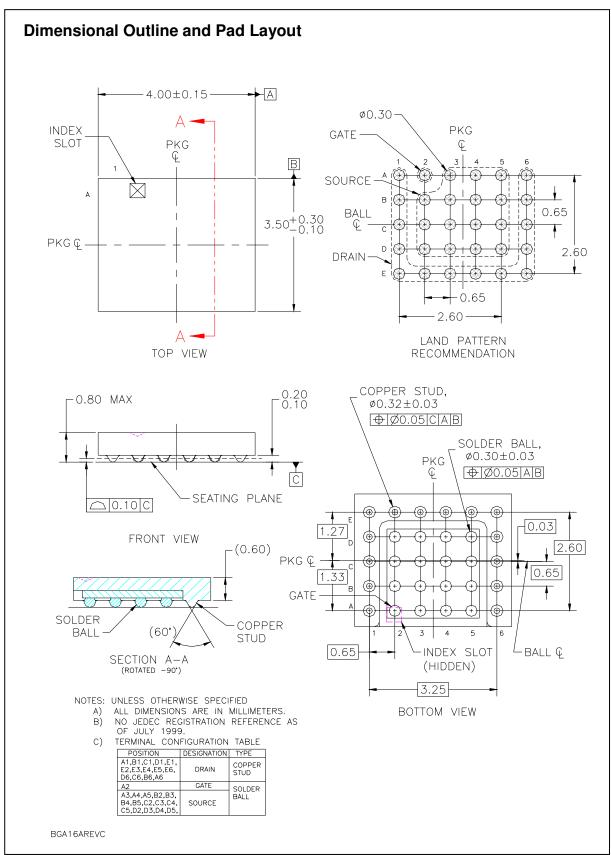
a) 56 °C/W when mounted on a 1in² pad of 2 oz copper



o) 119 ℃/W when mounted on a minimum pad of 2 oz copper

Scale 1:1 on letter size paper

2.Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%



Typical Characteristics

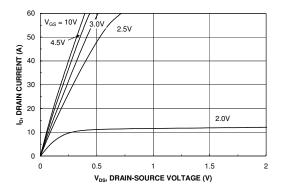


Figure 1. On-Region Characteristics.

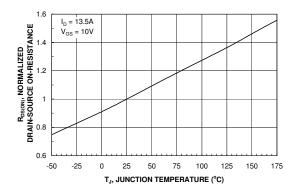


Figure 3. On-Resistance Variation with Temperature.

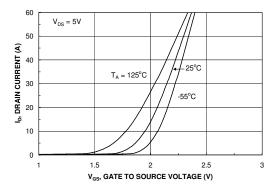


Figure 5. Transfer Characteristics.

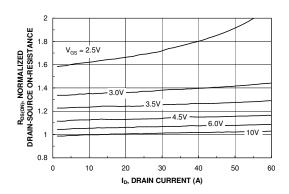


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

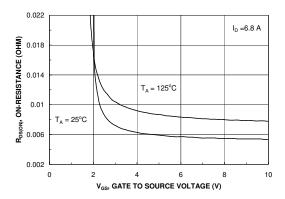


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

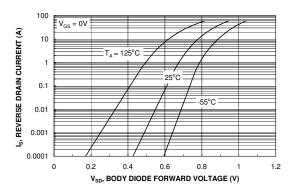
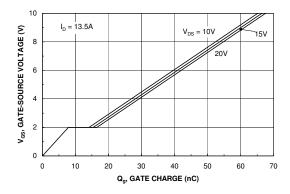


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



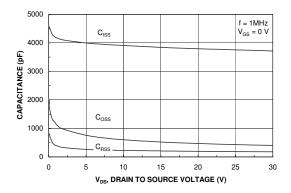
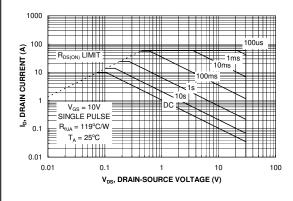


Figure 7. Gate Charge Characteristics.





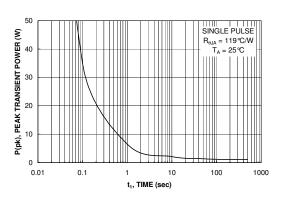


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

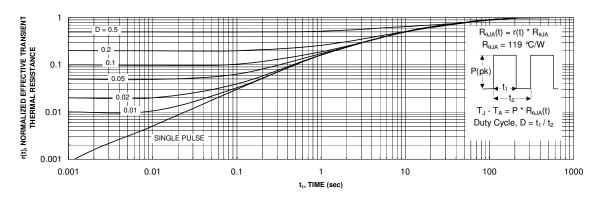


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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